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PTO/SB/08a/b (08-03)

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Substitute for form 1449A/B/PTO			Complete if Known	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)			Application Number	Not Yet Assigned 10/525 998
			Filing Date	Concurrently Herewith
			First Named Inventor	Shiro Sakai
			Art Unit	N/A
			Examiner Name	Not Yet Assigned
Sheet 1 of 1	Attorney Docket Number	08228/073001		

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T <sup>6</sup>
DL	BA	JP-2001-156331-A	06-08-2001	Nichia Kagaku Kogyo KK		
	BB	JP-2001-307506-A	11-02-2001	Hitachi Ltd.		
	BC	JP-2000-68555-A	03-03-2000	Hitachi Ltd.		
	BD	JP-10-107316-A	04-24-1998	Toyoda Gosei KK		
	BE	JP-10-275935-A	10-13-1998	Rohm Co. Ltd.		
	BF	JP-11-150303-A	06-02-1999	Sanyo Electric Co.		
	BG	JP-2000-101136-A	04-07-2000	Tokyo Shibaura Electric Co.		
DL	BH	JP-2002-26384-A	01-25-2002	Nichi Kagaku Kogyo KK		

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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
DL	CA	esp@cenet database - Worldwide patent abstract, publication no. JP2001156331, published on June 8, 2001 (1 page)	
	CB	esp@cenet database - Worldwide patent abstracts, publication number JP2001307506, published on November 2, 2001 (1 page)	
	CC	esp@cenet database - Worldwide patent abstracts, publication number JP2000068555, published March 3, 2000 (1 page)	
	CD	esp@cenet database - Worldwide patent abstracts, publication number JP10107316, published on April 24, 1998 (1 page)	
	CE	esp@cenet database - Worldwide patent abstracts, publication number JP10275935, published on October 13, 1998 (1 page)	
	CF	esp@cenet database - Worldwide patent abstracts, publication number JP11150303, published June 2, 1999 (1 page)	
	CG	esp@cenet database - Worldwide patent abstracts, publication number JP2000101136, published on April 7, 2000 (1 page)	
DL	CH	esp@cenet database - Worldwide patent abstracts, publication number JP2002026384, published on January 25, 2002 (1 page)	

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<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	<i>Michael H. Meyer</i>	Date Considered	2/15/06
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		Application Number	10/525,998-Conf. #6220		
		Filing Date	February 28, 2005		
		First Named Inventor	Shiro Sakai		
		Art Unit	2875		
		Examiner Name	Not Yet Assigned		
Sheet	1	of	1	Attorney Docket Number	08228/073001

U.S. PATENT DOCUMENTS					
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		Country Code <sup>3</sup> -Number <sup>2</sup> -Kind Code <sup>2</sup> (if known)	MM-DD-YYYY			
MR	BA**	JP-2001-156331-A	06-08-2001	Nichia Kagaku Kogyo KK		
	BB**	JP-2001-307506-A	11-02-2001	Hitachi Ltd.		
	BC**	JP-2000-68555-A	03-03-2000	Hitachi Ltd.		
MR	BD	JP-59-206873	11-22-1984			

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MR	CA	Japanese Office Action for Japanese Application No. <u>2002-249957</u> dated April 26, 2005, 3 pages		✓
	CB**	esp@cenet database – Worldwide Patent Abstract, Publication No. JP2001156331, Publication Date 06/08/2001, 1 page		
	CC**	esp@cenet database – Worldwide Patent Abstract, Publication No. JP2001307506, Publication Date 11/02/2001, 1 page		
	CD**	esp@cenet database – Worldwide Patent Abstract, Publication No. JP2000068555, Publication Date 03/03/2000, 1 page		
	CE	English language excerpt from Japanese Patent Laid-Open Publication No. 59-206873 published 11/22/1984, 1 page		
MR	CF	"Monolithic Blue LED Series Arrays for High-Voltage AC Operation," written by Jin-Ping Ao et al.; presented at the International Workshop on Nitride Semiconductors (IWN 2002) in Aachen, Germany, July 22-25, 2002.		

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Examiner Signature	<i>Michael S. Meyer</i>	Date Considered	2/15/06
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